

IEEE JOSEPH F. KEITHLEY AWARD IN INSTRUMENTATION & MEASUREMENT
RECIPIENTS

2017	JEROME JOHN BLAIR Chief Scientist, Keystone International, Riverside, California, USA	"For contributions to test procedures for analog-to-digital and digital-to-analog converters and to enhanced-accuracy gamma-ray spectrometry."
2016	SAMUEL BENZ Superconducting Electronics Group Leader and NIST Fellow, National Institute of Standards and Technology, Boulder, Colorado, USA	"For creating and disseminating quantum-based superconducting voltage standards that form the basis for worldwide precision voltage measurements."
2015	JEAN-CHARLES BOLOMEY Emeritus Professor, University Paris Sud, Paris, France	"For pioneering contributions to efficient modulated probe array technology for fast electromagnetic near-field techniques and microwave imagery."
2014	THOMAS E. LINNENBRINK Manager, Teqovations, LLC, Colorado Springs, Colorado, USA	"For pioneering charge-mode analog-to-digital converters and for developing IEEE-standard converter terminology and test methods."
2013	DYLAN FORREST WILLIAMS Electrical Engineer, National Institute of Standards and Technology (NIST), Boulder, CO, USA	"For the development of traceable mismatch-corrected microwave-scattering parameters and temporal waveform calibration and measurement."
2012	RIK PINTELON Professor, Vrije Universiteit Brussel, Brussels, Belgium	"For the development of innovative system identification methods for measurement applications."
2011	REZA ZOUGHBI Schlumberger Distinguished Prof., Missouri University of Science and Technology Rolla, MO, USA	"For contributions to microwave and millimeter wave measurement techniques for nondestructive testing and evaluation."
2010	No Award	
2009	BRIAN PETER KIBBLE Retired, National Physical Laboratory Middlesex, United Kingdom	"For pioneering experiments and techniques in the field of fundamental electrical metrology leading to the realization of SI units."
2008	ROBERT G. FULKS Vice President, GenRad Inc	"For pioneering developments in automated measurements."

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North Chatham, MA USA

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| 2007 | DOUGLAS KENT RYTTING
Rytting Consulting
Santa Rosa, CA, USA | "For seminal technical and leadership contributions to microwave network analyzer technology." |
| 2006 | ALESSANDRO M. FERRERO
Professor, Politecnico di Milano
Dipartimento di Electrotecnica,
Milano, Italy | "For advancing the measurement of electrical quantities in electric power systems under non-sinusoidal conditions." |
| 2005 | CLARK A. HAMILTON
President and CEO, Vmetrix, LLC
Boulder, CO, USA | "For making the dc Josephson array voltage standard a practical reality." |
| 2004 | HENRY PARSONS HALL
Retired/Senior Staff Scientist
GenRad, Inc.
Westford, MA, USA | "For fundamental contributions to electrical measurements, with particular emphasis on the development of impedance bridges and standards, and the application of microprocessors to impedance measurement science." |
| 2003 | NOT AWARDED | |